

1 Proceedings

2 Physical investigation of spin-coated MoS₂ films †

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12 **Abstract:** Amongst emerging Transition Metal Dichalcogenides (TMDCs), molybdenum disulfide
13 (MoS₂) has attracted a remarkable interest thanks to many possible applications. In particular,
14 MoS₂ has potentialities not yet fully realized in solution-based applications. The morphological and
15 the structural properties of MoS₂ films deposited by spin-coating onto Si/SiO₂ substrates were
16 investigated by Scanning Electron Microscopy (SEM), Atomic Force Microscopy (AFM) and
17 Micro-Raman Spectroscopy. High resolution AFM imaging highlights the presence of a layered
18 structure. The thickness of each layer is estimated to be around 13 nm. Micro-Raman
19 measurements reveal that there is the coexistence of both 2H-MoS₂ and 1T-MoS₂ phases, which
20 could be useful for electrical applications. Moreover, the band at 290 cm⁻¹ is assigned to the
21 amorphous phase of MoS₂. The detectability of the mode E_{1g} in back scattering geometry is ascribed
22 to the disorder of the amorphous phase.

23 **Keywords:** thin films; molybdenum disulfide; Transition Metal Dichalcogenides
24

25 1. Introduction

26 Among Transition Metal Dichalcogenides (TMDCs), molybdenum disulfide (MoS₂) offers
27 several advantages because of its unique and tunable electronic properties. A simple model to
28 describe the structure of MoS₂ states that one molybdenum (Mo) atom is covalent bonded with three
29 sulfur (S) atoms on the top and three S atoms on the bottom in a prismatic way. A layer is obtained
30 when the prismatic structure is repeated infinite times on one plane; in this way one layer is made by
31 a plane of Mo atoms enclosed in two planes of S atoms [1]. While the bonds among the different
32 atoms inside a layer are covalent, the addition of others layers occurs by Van der Waals interactions,
33 weaker than the former, among the different atoms of each layer [1]. MoS₂ shows mainly two phases:
34 one with a trigonal prismatic structure (2H-MoS₂) and one with an octahedral structure (1T-MoS₂).
35 The two phases exhibit completely different electronic structures: 2H-MoS₂ phase is semiconducting
36 while 1T-MoS₂ is metallic [2]. In Ref. [3], Eda et al. have shown that 2H/1T hybrid structures coexist
37 in chemically exfoliated MoS₂ nanosheets.

38 Scalable production of 2D materials can be achieved by solution-based exfoliation methods [4].
39 In particular, MoS₂ has potentialities not yet fully realized in solution-based applications [5].

40 Scanning Electron Microscopy (SEM), Atomic Force Microscopy (AFM) and Micro-Raman
41 spectroscopy measurements were carried out on MoS₂ films spin-coated onto Si/SiO₂ substrates.

42 Micro-Raman spectroscopy measurements reveal the coexistence of 2H-MoS₂ and 1T-MoS₂
43 phases, which is useful for electrical applications [6].

44 2. Materials and Methods

45 Silicon (Si) wafers used as substrates were ultrasonically cleaned in acetone, then in
46 double-distilled water and isopropanol. At the end, they were dried with warm air.

47 The commercial aqueous solution of MoS₂ dispersion 0.1-0.5 mg in H₂O, which was obtained by
48 solution-based exfoliation methods, was bought from Sigma Aldrich. The solution was sonicated for
49 30 minutes using an ultrasonic bath.

50 MoS₂ films were reproducibly prepared by spin-coating the solution onto Si/SiO₂ substrates
51 (SiO₂ thickness of ~2 nm). The results are reported on samples prepared at 6000 rpm spin coating
52 speed and 60 s as deposition time.

53 The MoS₂ flakes were characterized by scanning transmission electron microscope (STEM). A
54 drop of the sample solution was placed on a Formvar/carbon on 300 gold mesh type S162A3 (Agar
55 Scientific) and dried at room temperature. SEM analysis was accomplished with a FEI Quanta FEG
56 400 F7 eSEM microscope.

57 Tapping mode AFM images were obtained in ambient conditions with a Multimode 8 equipped
58 with a Nanoscope V controller (Bruker Instruments). Images were acquired using cantilevers with a
59 force constant $k=5 \text{ Nm}^{-1}$ (model TAP150A, Bruker). The scan line speed was optimized between 1
60 and 3 Hz over 512×512 pixels. Image processing and analysis were carried out using the free
61 software WSxM [7].

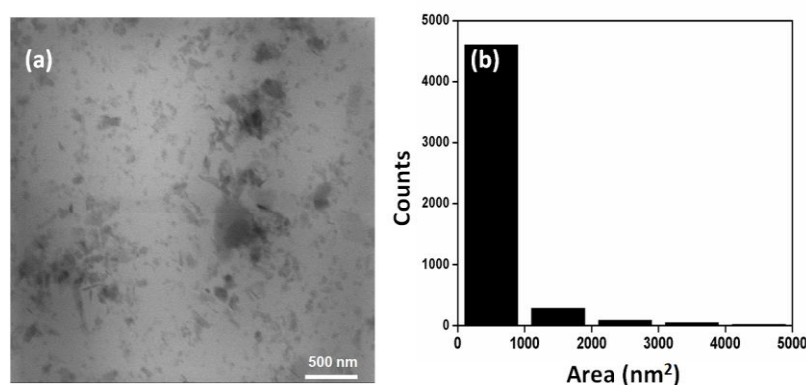
62 Micro-Raman spectra were collected by using a Horiba-Jobin Yvon microprobe apparatus
63 (spectral resolution ~2 cm⁻¹), equipped with a CCD (256 × 1024 pixels) detector cooled at -70°C and
64 with a 532 nm line of a diode laser, with an emitted power of 50 mW. The laser spot was about 2–3
65 μm of apparent diameter. Heating filter with different optical density were used to avoid structural
66 changes due to laser.

67 3. Results and discussion

68 3.1. STEM, SEM and AFM measurements

69 A STEM image of MoS₂ flakes drop-casted onto a gold mesh is reported in Figure 1 (a).

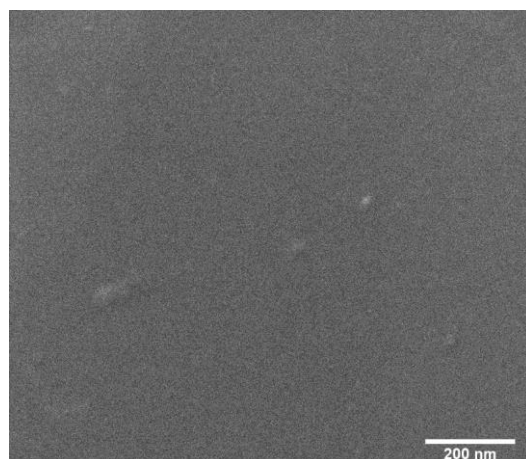
70 The size distribution of the MoS₂ flakes areas is shown in Figure 1 (b), in which it is evident that
71 most MoS₂ aggregates have dimensions less than 30 nm.



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73 **Figure 1.** STEM image of drop-casted MoS₂ flakes onto a gold mesh (a) and size distribution of MoS₂
74 flakes areas (b).

75 A SEM image of MoS₂ films spin-coated onto Si/SiO₂ substrate is reported in Figure 2.



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Figure 2. SEM image of spin-coated MoS₂ films onto Si/SiO₂ substrates.

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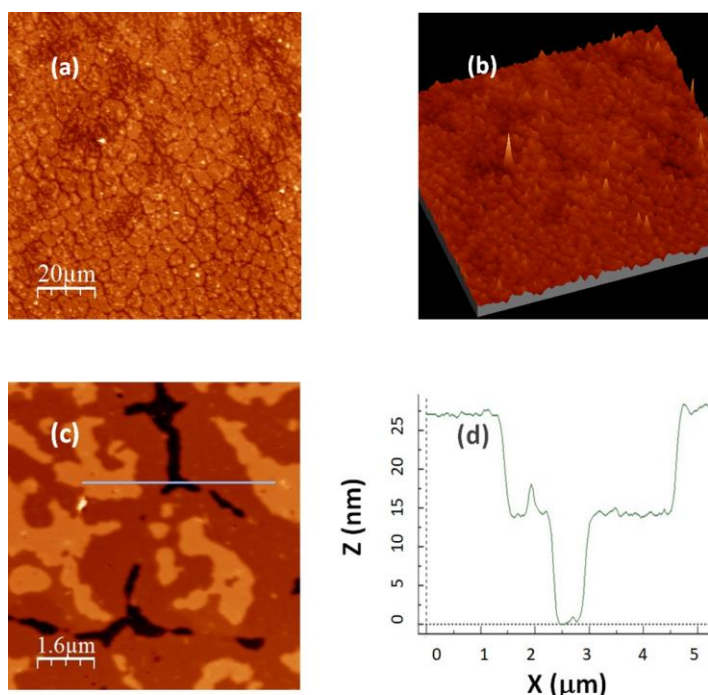
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The surface topographies of MoS₂ films spin-coated onto Si/SiO₂ substrates were characterized by AFM analysis. The investigated areas show a homogeneous MoS₂ deposition on the surface as reported in Figure 3 in a 2D (a) and a 3D representation (b). Root mean square roughness measured on 100x100 μm² areas is (7.0±1.5) nm. High resolution AFM imaging highlights the presence of a layered structure, visible in small areas in Figure 3 (c). The thickness of each layer is estimated to be (13±2) nm, as it is reported in the line profile shown in Figure 3 (d).



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Figure 3. AFM surface images of MoS₂ films spin-coated onto Si/SiO₂ substrates acquired on a 100x100 μm² area in a 2D (a) and 3D (b) representation. Image acquired on an 8x8 μm² area (c) and profile along the cyan line (d).

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3.2. Micro-Raman spectroscopy measurements

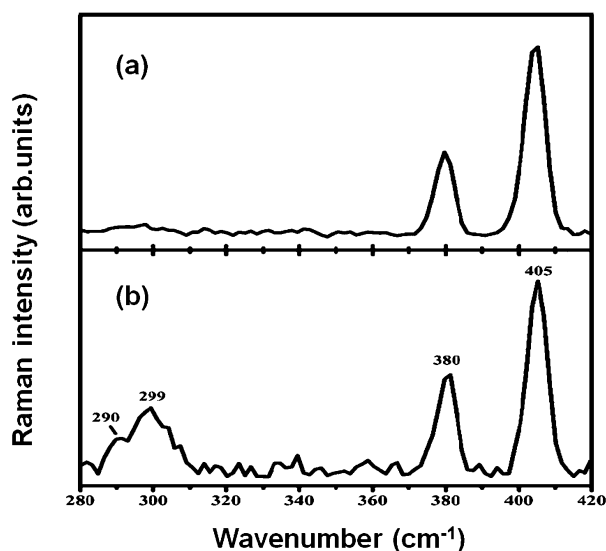
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The main Raman modes of MoS₂ are E_{1g} (286 cm⁻¹), E_{2g}¹ (383 cm⁻¹), A_{1g} (408 cm⁻¹) and E_{2g}² (32 cm⁻¹) [8].

91 The E_{1g} , E_{2g}^1 , and E_{2g}^2 are in-plane Raman active modes while the A_{1g} is out of plane. The
 92 E_{2g}^1 are vibrations of Mo and S planes in opposite direction in the MoS₂ structure, while the E_{2g}^2
 93 are assigned to the vibrations of Mo and S planes in the same direction. The A_{1g} mode is due to the
 94 vibrations of only S atoms along the c axis while the E_{1g} mode is ascribed to the in-plane vibrations
 95 of S atoms [9].

96 In figure 4 the representative Raman spectra collected on MoS₂ films spin-coated onto Si/SiO₂
 97 substrates are reported.



98

99 **Figure 4.** Representative Micro-Raman spectra collected on MoS₂ films spin-coated onto Si/SiO₂
 100 substrates; 2H-MoS₂ phase (a) and 1T-MoS₂ phase (b).

101 As it can be seen in Figure 4 (a), the only present modes are E_{2g}^1 and A_{1g} , which fall at about
 102 380 cm⁻¹ and 405 cm⁻¹, respectively. The position of the high frequency mode indicates that the MoS₂
 103 sample is monolayer, while the other mode seems to indicate a multilayer structure [1]. Such
 104 findings indicate that Figure 4 (a) has been collected on 2H-MoS₂.

105 In Figure 4 (b), in addition to the bands seen in Figure 4 (a), the bands at about 290 cm⁻¹ and 299
 106 cm⁻¹ are clearly detectable. Even though the E_{1g} mode is Raman forbidden in back scattering
 107 geometry [10], these two modes are assigned to E_{1g} . In particular, the mode at 299 cm⁻¹ is associated
 108 to 1T-MoS₂ [2], while the band at 290 cm⁻¹ is assigned to the amorphous phase of MoS₂ [11]. The
 109 detectability of the E_{1g} mode, even in back scattering geometry, is ascribed to the disorder of the
 110 amorphous phase.

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114 **Conflicts of Interest:** The authors declare no conflict of interest.

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